

United States Patent and Trademark Office



UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/447,301	11/23/1999	SATOSHI YOSHIHARA	P99.1899	3648
33448 ROBERT J. DF	7590 01/09/200 EPK E	EXAMINER		
LEWIS T. STE	CADMAN	HANNETT, JAMES M		
ROCKEY, DEPKE, LYONS AND KITZINGER, LLC SUITE 5450 SEARS TOWER CHICAGO, IL 60606-6306			ART UNIT	PAPER NUMBER
			2622	-
SHORTENED STATUTOR	Y PERIOD OF RESPONSE	MAIL DATE	DELIVERY MODE	
3 MONTHS		01/09/2007	PAPER	

Please find below and/or attached an Office communication concerning this application or proceeding.

If NO period for reply is specified above, the maximum statutory period will apply and will expire 6 MONTHS from the mailing date of this communication.

	Application No.	Applicant(s)			
•	09/447,301	YOSHIHARA, SATOSHI			
Office Action Summary	Examiner	Art Unit			
	James M. Hannett	2622			
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address			
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tin will apply and will expire SIX (6) MONTHS from a cause the application to become ABANDONE	N. nely filed the mailing date of this communication. D (35 U.S.C. § 133).			
Status					
1)⊠ Responsive to communication(s) filed on 18 Octo 2a)⊠ This action is FINAL . 2b)□ This 3)□ Since this application is in condition for allowar closed in accordance with the practice under Expression is the practice of the condition of the practice of the condition of t	action is non-final. nce except for formal matters, pro				
Disposition of Claims					
4) Claim(s) 1 and 3-18 is/are pending in the application 4a) Of the above claim(s) is/are withdraw 5) Claim(s) is/are allowed. 6) Claim(s) 1 and 3-18 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/or	vn from consideration.				
Application Papers					
9) ☐ The specification is objected to by the Examine 10) ☑ The drawing(s) filed on 23 November 1999 is/a Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) ☐ The oath or declaration is objected to by the Ex	re: a) \boxtimes accepted or b) \square object drawing(s) be held in abeyance. Se ion is required if the drawing(s) is ob	e 37 CFR 1.85(a). jected to. See 37 CFR 1.121(d).			
Priority under 35 U.S.C. § 119					
12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) ⊠ All b) ☐ Some * c) ☐ None of: 1. ☑ Certified copies of the priority documents have been received. 2. ☐ Certified copies of the priority documents have been received in Application No 3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received.					
Attachment(s)					
 Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date 	4) Interview Summary Paper No(s)/Mail D 5) Notice of Informal F 6) Other:	ate			

Art Unit: 2622

DETAILED ACTION

Response to Arguments

Applicant's arguments filed 10/18/2006 have been fully considered but they are not persuasive. The applicant has amended the independent claims to state that there is a readout gate between the image array and the accumulation gate. The examiner asserts that Elabd et al teaches on Column 5, Lines 14-40 the use of a dump drain (35) depicted in Figure 6A that is formed by gates (53,55,35 and 51) This is viewed by the examiner as a readout gate since the charge from the image array needs to pass through the dump drain to be stored in the storage register.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 1: Claims 1, 3-8, 11, 12, 15, 17 and 18 are rejected under 35 U.S.C. 102(b) as being anticipated by USPN 5,196,939 Elabd et al.
- 2: As for Claim 1, Elabd et al depicts in Figure 4 and teaches on Column 1, Lines 65-68 and Column 2, Lines 12-17 and Column 4, Lines 28-41 and Column 6, Lines 16-20 a solid state image pickup device (31) having a sensor array (13) comprising a plurality of sensors; and a plurality of transfer registers (17A and 17B) for transferring signal charges from the sensors of the sensor array, at least one horizontal-horizontal transfer register; Figure 6A (45 and 47) is formed between said transfer registers (17A and 17B) for storing temporarily and transferring said signal charges: wherein an accumulation gate (33) is provided between said sensor array and

Art Unit: 2622

said transfer registers for reading out signal charges from the sensors at a same time, accumulating the signal charges and allocating the signal charges to the transfer registers. Elabd et al depicts in Figure 4 the plurality of transfer registers (17A and 17B) include two transfer registers (17A and 17B) which receive and concurrently transfer charges from at least two Columns (15) of pixels of the image sensor (31). Elabd et al teachers on Column 1, Lines 66-68 and Column 2, Lines 18 and depicts in Figure 4 that only one row is read out of the image sensor at a time and transferred to the storage register (33). Elabd et al further teaches on Column 2. Lines 60-68 and Column 5, Lines 28-35 that the rows of image data transferred to the storage register (33) can be combined using storage site (59) to permit rows to be combined for less detail and a variety of other options. Therefore, in the embodiment discussed on Column 2, Lines 60-68, multiple rows of data are combined in storage register (33) and the then combined pixel value is transferred to transfer registers (17A and 17B). Therefore, transfer register 17A receives charges stored in even-numbered columns from the two mixed rows of image data. And transfer register 17B receives charges stored in odd-numbered columns from the two mixed rows of image data. Therefore, in the thinned readout mode the transfer registers concurrently read out image data from two rows of pixels (the two rows of data are mixed). Elabd et al teaches on Column 5, Lines 14-40 the use of a dump drain (35) depicted in Figure 6A that is formed by gates (53,55,35 and 51) This is viewed by the examiner as a readout gate since the charge from the image array needs to pass through the dump drain to be stored in the storage register.

3: As for Claim 3, Elabd et al depicts in Figures 6B-F and teaches on Column 6, Lines 16-28 The accumulation gate (storage register) creates a difference in electric potential oriented in a direction of transfer. Elabd et al teaches that by clocking the gates overlaying the storage register

Art Unit: 2622

the charge will be transferred to the transfer register. Therefore, the storage register sets a difference in electric potential oriented in the direction or the transfer registers.

- 4: In regards to Claim 4, Elabd et al teaches on Column 4, Lines 42-48 and Column 6, Lines 3-6 that the signal charges of the sensors are stored in the accumulation gate (storage register 33) to be allocated in units of electrical charge each originated by one of the sensors. Elabd et al teaches that the charges from all of the pixels in the image sensor array are output individually by row to the storage register (33), which is viewed as the accumulation gate.
- 5: As for Claim 5, Elabd et al teaches on Column 4, Lines 42-48 The signal charges of the sensors are allocated to respective transfer registers for each odd sensor and each even sensor of the sensor array. Elabd et al teaches that transfer register 17A receives the charge stored in the even-numbered columns of the transferred row, and transfer register 17B receives charge stored in the odd-numbered columns of the transferred row.
- 6: In regards to Claim 6, Elabd et al depicts in Figure 4 and teaches on Column 1, Lines 65-68 and Column 2, Lines 12-17 and Column 4, Lines 28-41 and Column 6, Lines 16-20 a method of driving a solid-state image pickup device having: a sensor array (31) comprising a plurality of sensors (13); a plurality of transfer registers (17A and 17B) for transferring signal charges from the sensors of the sensor array; at least one horizontal-horizontal transfer register (45 and 47) formed between said transfer registers (17A and 17B) for storing temporarily and transferring said signal charges; Figure 6A (45 and 47): an accumulation gate (33) provided between the sensor array and the transfer registers, the method comprising the steps of: reading out signal charges from all of the sensors in a row closest to the accumulation gate at the same time; allocating the signal charges of the sensors from the accumulation gate to the transfer registers;

Art Unit: 2622

and driving the transfer registers to output the signal charges. Elabd et al depicts in Figure 4 the plurality of transfer registers (17A and 17B) include two transfer registers (17A and 17B) which receive and concurrently transfer charges from at least two Columns (15) of pixels of the image sensor (31). Elabd et al teachers on Column 1, Lines 66-68 and Column 2, Lines 18 and depicts in Figure 4 that only one row is read out of the image sensor at a time and transferred to the storage register (33). Elabd et al further teaches on Column 2, Lines 60-68 and Column 5, Lines 28-35 that the rows of image data transferred to the storage register (33) can be combined using storage site (59) to permit rows to be combined for less detail and a variety of other options. Therefore, in the embodiment discussed on Column 2, Lines 60-68, multiple rows of data are combined in storage register (33) and the then combined pixel value is transferred to transfer registers (17A and 17B). Therefore, transfer register 17A receives charges stored in evennumbered columns from the two mixed rows of image data. And transfer register 17B receives charges stored in odd-numbered columns from the two mixed rows of image data. Therefore, in the thinned readout mode the transfer registers concurrently read out image data from two rows of pixels (the two rows of data are mixed). Elabd et al teaches on Column 5, Lines 14-40 the use of a dump drain (35) depicted in Figure 6A that is formed by gates (53,55,35 and 51) This is viewed by the examiner as a readout gate since the charge from the image array needs to pass through the dump drain to be stored in the storage register.

7: As for Claim 7, Elabd et al depicts in Figure 6A and teaches on Column 5, Lines 14-58 that the transfer registers (17A and 17B) are driven at the same time. Elabd et al teaches that both transfer registers are driven by Signals (H1-H4) Since these signals are supplied to both transfer registers, they are driven at the same time.

Art Unit: 2622

- 8: In regards to Claim 8, Elabd et al teaches on Column 4, Lines 42-48 the signal charges of the sensors are allocated to respective transfer registers for each odd sensor and each even sensor of the sensor array. Elabd et al teaches that transfer register 17A receives the charge stored in the even-numbered columns of the transferred row, and transfer register 17B receives charge stored in the odd-numbered columns of the transferred row.
- 9: As for Claim 11, Elabd et al depicts in Figure 6A that the accumulation gate (41A and 41B) and the read-out gate (15A) share a common gate electrode. The Figure depicts that the image data is transferred using the same electrode from the image array to the storage register and then to the transfer registers.
- 10: In regards to Claim 12, Elabd et al depicts in Figure 6A that the step of reading out and the step of allocating are carried out through a common gate electrode. The Figure depicts that the image data is transferred using the same electrode from the image array to the storage register and then to the transfer registers.
- 11: As for Claim 15, Elabd et al teaches in Table 1 on Column 8, Lines 10-45 that the readout gate and the accumulation gate are comprised of a same material.
- 12: In regards to Claim 17, Elabd et al teaches on Column 4, Lines 28-41 and depicts in Figure 6A the readout gate (53,55,35 ands 51) transmits all received signals from the sensor array to the accumulation gate (storage register) and the accumulation gate (storage register) subsequently transfers all of the signals to the transfer registers (17A and 17B). This process occurs if the rows have been selected.
- 13: As for Claim 18, Elabd et al teaches on Column 4, Lines 28-41 and depicts in Figure 6A the readout gate (53,55,35 ands 51) transmits all received signals from the sensor array to the

Art Unit: 2622

accumulation gate (storage register) and the accumulation gate (storage register) subsequently transfers all of the signals to the transfer registers (17A and 17B). This process occurs if the rows have been selected.

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

- (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 14: Claims 9 and 10 are rejected under 35 U.S.C. 103(a) as being unpatentable over USPN 5,196,939 Elabd et al in view of USPN 5,298,734 Kokudo.
- 15: As for Claim 9, Elabd et al teaches the claimed invention as discussed in Claim 1. Elabd et al teaches the use of an image sensor that has two horizontal transfer registers that each output odd and even column data respectively. Therefore, the channel stop region between the transfer registers (17A and 17B) have half the number of columns as the transfer registers to allow only half of the columns to pass from transfer register (17A) to transfer register (17B). However, Elabd et al does note teach that the horizontal-horizontal transfer unit has the same number of columns as the transfer registers.

Kokudo teaches in Figure 2 and teaches on Column 4, Lines 10-27 that it is advantageous when designing an image sensor that has two horizontal transfer registers to allow all of the column data from the first transfer register to be transferred to the second transfer register in order to enable the image sensor to perform a progressive scan readout and output two lines of image data simultaneously. Because the entire row of image data can be transferred from the first

Art Unit: 2622

transfer register to the second transfer register, it is inherent that the horizontal-horizontal transfer register between them have the same number of columns as the two registers.

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to enable the image sensor of Elabd et al to use a horizontal-horizontal transfer register as taught by Kokudo in the invention of Eladb et al to enable the image sensor to perform a progressive scan readout while reading out two rows of image data simultaneously.

16: In regards to Claim 10, Elabd et al teaches the claimed invention as discussed in Claim 6. Elabd et al teaches the use of an image sensor that has two horizontal transfer registers that each output odd and even column data respectively. Therefore, the channel stop region between the transfer registers (17A and 17B) have half the number of columns as the transfer registers to allow only half of the columns to pass from transfer register (17A) to transfer register (17B). However, Elabd et al does note teach that the horizontal-horizontal transfer unit has the same number of columns as the transfer registers.

Kokudo teaches in Figure 2 and teaches on Column 4, Lines 10-27 that it is advantageous when designing an image sensor that has two horizontal transfer registers to allow all of the column data from the first transfer register to be transferred to the second transfer register in order to enable the image sensor to perform a progressive scan readout and output two lines of image data simultaneously. Because the entire row of image data can be transferred from the first transfer register to the second transfer register, it is inherent that the horizontal-horizontal transfer register between them have the same number of columns as the two registers.

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to enable the image sensor of Elabd et al to use a horizontal-horizontal

Art Unit: 2622

transfer register as taught by Kokudo in the invention of Eladb et al to enable the image sensor to perform a progressive scan readout while reading out two rows of image data simultaneously.

17: Claims 13, 14 and 16 are rejected under 35 U.S.C. 103(a) as being unpatentable over USPN 5,196,939 Elabd et al in view of USPN USPN 6,028,299 Hirmada et al.

As for Claim 13, Elabd et al depicts in Figure 4 and teaches on Column 1, Lines 65-68 18: and Column 2, Lines 12-17 and Column 4, Lines 28-41 and Column 6, Lines 16-20 a solid state image pickup device (31) having a sensor array (13) comprising a plurality of sensors; and a plurality of transfer registers (17A and 17B) for transferring signal charges from the sensors of the sensor array, at least one horizontal-horizontal transfer register; Figure 6A (45 and 47) is formed between said transfer registers (17A and 17B) for storing temporarily and transferring said signal charges: wherein an accumulation gate (33) is provided between said sensor array and said transfer registers for reading out signal charges from the sensors at a same time, accumulating the signal charges and allocating the signal charges to the transfer registers. The accumulation gate is viewed by the examiner as the storage register (33). The horizontalhorizontal transfer region is viewed by the examiner as the transfer region (47) that transfers charge between the two transfer registers (17A and 17B). Elabd et al depicts in Figure 4 the plurality of transfer registers (17A and 17B) include two transfer registers (17A and 17B) which receive and concurrently transfer charges from at least two Columns (15) of pixels of the image sensor (31). Elabd et al teachers on Column 1, Lines 66-68 and Column 2, Lines 18 and depicts in Figure 4 that only one row is read out of the image sensor at a time and transferred to the storage register (33). Elabd et al teaches on Column 5, Lines 14-40 the use of a dump drain (35) depicted in Figure 6A that is formed by gates (53,55,35 and 51) This is viewed by the examiner

Art Unit: 2622

as a readout gate since the charge from the image array needs to pass through the dump drain to be stored in the storage register. Elabd et al further teaches on Column 2, Lines 60-68 and Column 5, Lines 28-35 that the rows of image data transferred to the storage register (33) can be combined using storage site (59) to permit rows to be combined for less detail and a variety of other options. Therefore, in the embodiment discussed on Column 2, Lines 60-68, multiple rows of data are combined in storage register (33) and the then combined pixel value is transferred to transfer registers (17A and 17B). Therefore, transfer register 17A receives charges stored in even-numbered columns from the two mixed rows of image data. And transfer register 17B receives charges stored in odd-numbered columns from the two mixed rows of image data. Therefore, in the thinned readout mode the transfer registers concurrently read out image data from two rows of pixels (the two rows of data are mixed). However, Elabd et al does not teach that the image array can be directly connected to accumulation gate without any vertical shift registers between them.

Hirmada et al teaches on Column 1, Lines 32-60 and depicts in Figure 1 the use of a linear image sensor in which the accumulation gate 29A is directly connected to the sensor array (22) via a readout gate (ROG). This is capable because the sensor array in Hirmada et al is a linear array and requires no vertical shift register. Linear image sensors are advantageous to use in document scanning systems.

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to directly connect the linear sensor of Hirmada et al to the accumulation gate of Elabd et al in order to allow the imaging system of Elabd et al to be used in an image scanning system in which a linear sensor is required.

Page 11

19: In regards to Claim 14, Elabd et al depicts in Figure 4 and teaches on Column 1, Lines 65-68 and Column 2, Lines 12-17 and Column 4, Lines 28-41 and Column 6, Lines 16-20 a solid state image pickup device (31) having a sensor array (13) comprising a plurality of sensors; and a plurality of transfer registers (17A and 17B) for transferring signal charges from the sensors of the sensor array, at least one horizontal-horizontal transfer register; Figure 6A (45 and 47) is formed between said transfer registers (17A and 17B) for storing temporarily and transferring said signal charges: wherein an accumulation gate (33) is provided between said sensor array and said transfer registers for reading out signal charges from the sensors at a same time, accumulating the signal charges and allocating the signal charges to the transfer registers. The accumulation gate is viewed by the examiner as the storage register (33). The horizontalhorizontal transfer region is viewed by the examiner as the transfer region (47) that transfers charge between the two transfer registers (17A and 17B). Elabd et al teaches the method comprising the steps of: reading out signal charges from all of the sensors in a row closest to the accumulation gate at the same time; allocating the signal charges of the sensors from the accumulation gate to the transfer registers; and driving the transfer registers to output the signal charges. Elabd et al depicts in Figure 4 the plurality of transfer registers (17A and 17B) include two transfer registers (17A and 17B) which receive and concurrently transfer charges from at least two Columns (15) of pixels of the image sensor (31). Elabd et al teachers on Column 1, Lines 66-68 and Column 2, Lines 18 and depicts in Figure 4 that only one row is read out of the image sensor at a time and transferred to the storage register (33). Elabd et al teaches on Column 5. Lines 14-40 the use of a dump drain (35) depicted in Figure 6A that is formed by gates (53,55,35 and 51) This is viewed by the examiner as a readout gate since the charge from the

image array needs to pass through the dump drain to be stored in the storage register. Elabd et al further teaches on Column 2, Lines 60-68 and Column 5, Lines 28-35 that the rows of image data transferred to the storage register (33) can be combined using storage site (59) to permit rows to be combined for less detail and a variety of other options. Therefore, in the embodiment discussed on Column 2, Lines 60-68, multiple rows of data are combined in storage register (33) and the then combined pixel value is transferred to transfer registers (17A and 17B). Therefore, transfer register 17A receives charges stored in even-numbered columns from the two mixed rows of image data. And transfer register 17B receives charges stored in odd-numbered columns from the two mixed rows of image data. Therefore, in the thinned readout mode the transfer registers concurrently read out image data from two rows of pixels (the two rows of data are mixed). Elabd et al teaches the use of a three dimensional array and therefore, teaches the use of vertical shift registers to vertically shift the image data. However, Elabd et al does not teach that the image array can be directly connected to accumulation gate without any vertical shift registers between them.

Hirmada et al teaches on Column 1, Lines 32-60 and depicts in Figure 1 the use of a linear image sensor in which the accumulation gate 29A is directly connected to the sensor array (22) via a readout gate (ROG). This is capable because the sensor array in Hirmada et al is a linear array and requires no vertical shift register. Linear image sensors are advantageous to use in document scanning systems.

Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to directly connect the linear sensor of Hirmada et al to the accumulation

Art Unit: 2622

gate of Elabd et al in order to allow the imaging system of Elabd et al to be used in an image scanning system in which a linear sensor is required.

20: As for Claim 16, Elabd et al teaches in Table 1 on Column 8, Lines 10-45 that the readout gate and the accumulation gate are comprised of a same material.

Conclusion

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to James M. Hannett whose telephone number is 571-272-7309. The examiner can normally be reached on 8:00 am to 5:00 pm M-F.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Vivek Srivastava can be reached on 571-272-7304. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Application/Control Number: 09/447,301 Page 14

Art Unit: 2622

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

James M. Hannett

Examiner

Art Unit 2622

JMH January 4, 2007

> VIVEK SRIVASTAVA SUPERVISORY PATENT EXAMINER